


Search Notes 	Application/Control No. 10776736	Applicant(s)/Patent Under Reexamination DEWAELE, PIET
	Examiner Fujita, Katrina	Art Unit 2609

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
(382/289,128,131,132) text search only - see search history printouts	02/02/2007	KF
(378/4,20,37) text search only - see search history printouts	02/02/2007	KF
(702/150) text search only - see search history printouts	02/06/2007	KF
IEEE keyword and author search - see search history printouts	02/07/2007	KF
SPIE keyword and author search - see search history printouts	02/02/2007	KF
Updated (382/128,131,132) text search only - see search history printouts	01/16/2008	KF
Updated EAST text search - see search history printouts	05/13/2008	KF
Updated EAST text search - see search history printouts	01/16/2009	KF
Google Scholar text search - see search history printouts	01/14/2009	KF

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

/KATRINA FUJITA/
Examiner,Art Unit 2624